

Replacing SRAM with FM1608B, FM16W08, FM1808B, or FM18W08

About this document

Scope and purpose

AN100 provides the design considerations for replacing battery-backed SRAMs with FM1608B/FM16W08/FM1808B/FM18W08 F-RAM devices.

Intended audience

It is intended for users who plan to use FM1608B, FM16W08, FM1808B, or FM18W08 as a replacement for SRAM.

Table of contents

About this document	1
Table of contents	1
1 Introduction	1
2 Parallel F-RAM Design Considerations	2
2.1 Memory Access	2
2.2 Confirm Power Supply Level.....	2
3 Summary	3
Revision history	4

1 Introduction

Designs that require both nonvolatility through power-down events and the fast random access of SRAMs will often include batteries to hold the SRAM V_{DD} level up when system power is lost. Infineon offers a range of F-RAM and nvSRAM devices in different densities that are pin-compatible with industry-standard SRAMs and which solve this problem without requiring batteries. These two technologies, F-RAM and nvSRAM, have different values and characteristics.

This application note highlights the design considerations that you need to review when replacing an SRAM plus battery design with the F-RAM products FM1608B/FM16W08 (64-Kbit (8K x 8)) and FM1808B/FM18W08 (256-Kbit (32K x 8)).

Parallel F-RAM Design Considerations

2 Parallel F-RAM Design Considerations

2.1 Memory Access

SRAMs and these F-RAM devices begin each read/write cycle with a new address being driven before the chip-enable transitions LOW. For subsequent memory accesses, SRAMs allow the \overline{CE} to remain LOW while the address bus changes. These four F-RAM devices, FM1608B, FM16W08, FM1808B, and FM18W08, do not allow this signaling. Every F-RAM memory access requires a falling edge of \overline{CE} , and therefore the \overline{CE} pin cannot be held LOW as in an SRAM device. The \overline{CE} must be toggled HIGH to LOW to latch each new address and it must be HIGH for the specified pre-charge period after the access.

Note: This is applicable only to FM1608B, FM16W08, FM1808B, and FM18W08 devices. Other parallel F-RAM devices do not have this design constraint.

If you are modifying the existing design to use one of these F-RAM devices, you must check the memory controller’s timing compatibility to generate the needed \overline{CE} and the address timing. Each memory access requires a LOW transition of \overline{CE} . In many cases, this is the only change required. **Figure 1** shows an example of F-RAM signal relationships. **Figure 2** shows a common SRAM signal relationship that will not work for these F-RAM devices.

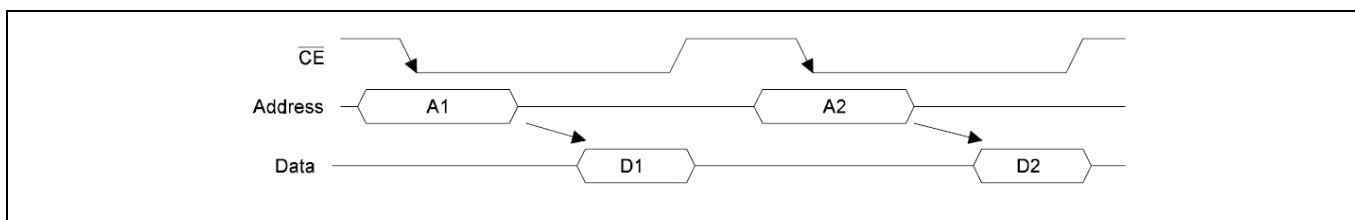


Figure 1 Valid Memory Read Relationship (F-RAM Signaling)

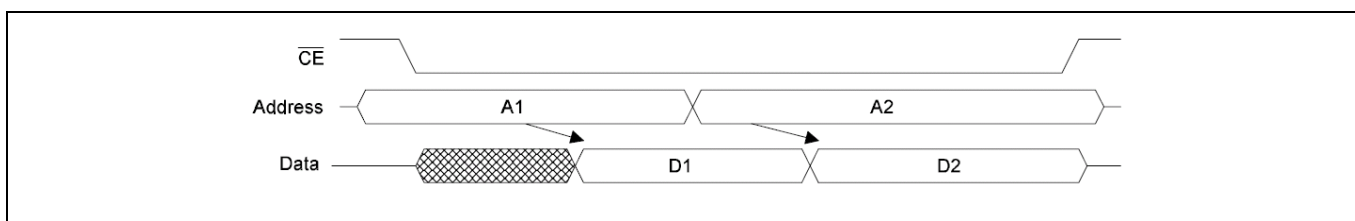


Figure 2 Invalid Memory Read Relationship (SRAM Signaling)

2.2 Confirm Power Supply Level

A second design consideration relates to the level of V_{DD} during device operation. Battery-backed SRAMs typically include a controller that monitors V_{DD} so the switch between V_{DD} and the battery happens as needed. Battery-backed SRAM devices typically block user access below a certain V_{DD} level to minimize the battery drain from an otherwise active SRAM. Therefore, in a power-down situation, you may be abruptly cut off from access to the memory without any warning. F-RAM memories do not need this system overhead. The memory will not block access at any V_{DD} level. However, you must prevent the processor from accessing the memory when V_{DD} is out of tolerance. Refer to the minimum and maximum V_{DD} specifications provided in the F-RAM datasheet. The common design practice of holding a processor in reset when V_{DD} drops is sufficient. You do not have to make any special provision for F-RAM designs.

Summary**3 Summary**

This application note provides design consideration for memory access when you replace battery-backed SRAMs with FM1608B/FM16W08/FM1808B/FM18W08 F-RAM devices. It also explains the benefit of F-RAM which removes the V_{DD} monitoring overhead in battery-backed SRAM systems.

Revision history**Revision history**

Document version	Date of release	Description of changes
**	2013-06-07	New Spec.
*A	2014-03-18	Updated the application note w.r.t battery-backed SRAM applications
*B	2016-06-02	Updated to new template.
*C	2017-08-17	Updated logo and copyright.
*D	2021-05-26	Migrated to IFX template.

Trademarks

All referenced product or service names and trademarks are the property of their respective owners.

Edition 2021-05-26

Published by

Infineon Technologies AG

81726 Munich, Germany

© 2021 Infineon Technologies AG.

All Rights Reserved.

Do you have a question about this document?

Go to www.cypress.com/support

Document reference

001-87059 Rev.*D

IMPORTANT NOTICE

The information contained in this application note is given as a hint for the implementation of the product only and shall in no event be regarded as a description or warranty of a certain functionality, condition or quality of the product. Before implementation of the product, the recipient of this application note must verify any function and other technical information given herein in the real application. Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind (including without limitation warranties of non-infringement of intellectual property rights of any third party) with respect to any and all information given in this application note.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

For further information on the product, technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies office (www.infineon.com).

WARNINGS

Due to technical requirements products may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies office.

Except as otherwise explicitly approved by Infineon Technologies in a written document signed by authorized representatives of Infineon Technologies, Infineon Technologies' products may not be used in any applications where a failure of the product or any consequences of the use thereof can reasonably be expected to result in personal injury.